



HIGH POWER TRIAC

Features:

- . Enlarged gate structure
- . Same silicon wafer contains two thyristors
- . Blocking capability up to 6500 volts
- . High power capability
- . Full cold pressing encapsulation



ELECTRICAL CHARACTERISTICS AND RATINGS

Blocking-Off State

Device No.	V _{DRM} (1)	V _{DSM} (1)
KS175/58	5800	5900
KS175/60	6000	6100
KS175/62	6200	6300
KS175/65	6500	6600

V_{DRM} = Repetitive peak off state voltage

V_{RSM} = Non Repetitive peak reverse voltage(2)

Repetitive peak reverse leakage and off state leakage	I _{DRM}	5 mA 100 mA (3)
Off - state voltage rise rating	dV/dt (4)	1000 V/sec (min)

Notes:

All ratings are specified for T_j=25 °C unless otherwise stated.

(1) All voltage ratings are specified for an applied 50Hz/60Hz sinusoidal waveform over the temperature range 0 to +125 °C

(2) 10 msec. Max. Pulse width

(3) Maximum value for T_j=125 °C.

(4) Minimum value for linear and exponential waveshape to 67% rated V_{DRM}. Gate open, T_j=125 °C

(5) The value of di/dt is established in accordance with EIA/NIMA Standard JB/T 8950.2-2013.

Conducting-on state

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Average value of on-state current	I _{T(AV)}		175		A	Sinewave,180° conduction,T _c =70°C
RMS value of on-state current	I _{TRMS}		275		A	Nominal value
Peak one cycle surge (non repetitive) current	I _{TSM}		1925		A	10.0 msec (50Hz), sinusoidal wave- shape, 180° conduction, T _j = 125 °C
I square t	I ² t		19x10 ³		A ² s	10 msec
Latching current	I _L		700		mA	V _D = 12 V; R _L = 12 ohms
Holding current	I _H		200		mA	V _D = 12 V; I = 2.5 A
Peak on-state voltage	V _{TM}		2.9		V	I _{TM} =300A;T _j =25°C
Threshold Voltage	V _{TO}		1.85		V	T _j =125°C
Slope resistance	r _T		3.5		mΩ	200A to 500A
Critical rate of rise of on-state current(5)	di/dt		100		A/μs	repetition
Commutator voltage rise rate rating	dV/dt			500	A/μs	T _j =125°C; VR≤0.67V _{DRM}

Gating

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Peak gate power dissipation	P _{GM}		200		W	
Average gate power dissipation	P _{G(AV)}		5		W	
Gate trigger current	I _{GT}		150		mA	V _D =12V; R _L =3ohms; T _j =+25°C
Gate trigger voltage	V _{GT}	0.8	2.5		V	V _D =12V; R _L =3ohms; T _j =+25°C
Peak negative voltage	V _{GRM}		5		V	

Dynamic

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Delay time	t _d		3.0		μs	I _{FG} =2.0A; V _D =0.4V _{DRM} ; t _r =0.5μs
Turn-off time (V _R =-5V)	t _q		700		μs	I _{TM} =175 A; di/dt =- 10A/μs; V _R =100 V; dV/dt=30V/μs ; V _D = 67%V _{DRM} ; T _j =125°C
Reverse recovery current	I _{rr}		1800		μC	I _{TM} =175A; di/dt=-1 A/s; V _R =100 V; T _j =125°C

THERMAL AND MECHANICAL CHARACTERISTICS AND RATINGS

Parameter	Symbol	Min.	Max.	Typ.	Units	Conditions
Operating temperature	T _j	-40	+125		°C	
Storage temperature	T _{stg}	-40	+140		°C	
Thermal resistance- junction to case	R _{θ(j-c)}		0.080		°C/W	Double sided cooled
Thermal resistance - case to heatsink	R _{θ(c-s)}		0.015		°C/W	Double sided cooled
Mounting force	P	12	15	14	kN	
Weight	W			0.4	kg.	

* Mounting surfaces smooth, flat and greased

